



STSJ60NH3LL

N-channel 30V - 0.004 Ω - 15A - PowerSO-8™
STripFET™ Power MOSFET for DC-DC conversion

General features

Type	V _{DSS}	R _{DS(on)}	I _D
STSJ60NH3LL	30V	<0.0057 Ω	15A ⁽²⁾

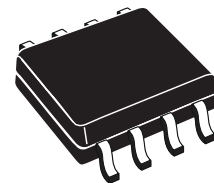
- Optimal R_{DS(on)} x Q_g trade-off @ 4.5 V
- Conduction losses reduced
- Improved junction-case thermal resistance
- Low threshold device

Description

This device utilizes the latest advanced design rules of ST's proprietary STripFET™ technology. This process coupled to unique metallization techniques realizes the most advanced low voltage Power MOSFET in SO-8 ever produced. The exposed slug reduces the R_{thj-c} improving the current capability.

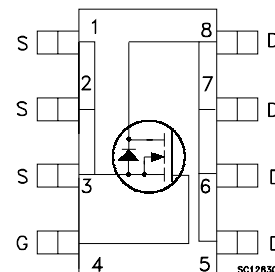
Applications

- Switching application



PowerSO-8™

Internal schematic diagram



DRAIN CONTACT ALSO ON THE BACKSIDE

Order codes

Part number	Marking	Package	Packaging
STSJ60NH3LL	60H3LL-	PowerSO-8™	Tape & reel

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1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	30	V
V_{GS}	Gate- source voltage	± 16	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	60	A
I_D	Drain current (continuous) at $T_C = 100^\circ\text{C}$	37.5	A
$I_D^{(2)}$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	15	A
I_D	Drain current (continuous) at $T_C = 100^\circ\text{C}$	9.4	A
$I_{DM}^{(3)}$	Drain current (pulsed)	60	A
$P_{tot}^{(1)}$	Total dissipation at $T_C = 25^\circ\text{C}$	50	W
$P_{tot}^{(2)}$	Total dissipation at $T_C = 25^\circ\text{C}$	3	W
T_{stg}	Storage temperature	-55 to 150	$^\circ\text{C}$
T_J	Operating junction temperature		

1. This value is rated according to R_{thj-c}
2. This value is rated according to $R_{thj-pcb}$
3. Pulse width limited by safe operating area

Table 2. Thermal resistance

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case (drain) Max	2.5	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-ambient Max	42	$^\circ\text{C/W}$

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250 μA, V _{GS} = 0	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating @125°C			1 10	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 16V			±100	nA
V _{GS(th)}	Gate threshold voltage	V _{DS} = V _{GS} , I _D = 250μA	1			V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 7.5A V _{GS} = 4.5V, I _D = 7.5A		0.004 0.005	0.0057 0.0075	Ω Ω

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1MHz, V _{GS} = 0		1810 565 41		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} =15V, I _D =15A V _{GS} =4.5V (see Figure 13)		18 4.8 5.3	24	nC nC nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain	0.5	1.5	3	Ω

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time Rise Time	$V_{DD} = 15V$, $I_D = 7.5A$ $R_G = 4.7\Omega$, $V_{GS} = 10V$ (see Figure 12)		8 65		ns ns
$t_{d(off)}$ t_f	Turn-off delay time Fall time	$V_{DD} = 15V$, $I_D = 7.5A$ $R_G = 4.7\Omega$, $V_{GS} = 10V$ (see Figure 12)		38 20		ns ns

Table 6. Source drain diode

Symbol	Parameter	Test conditions	Min	Typ.	Max	Unit
I_{SD} I_{SDM}	Source-drain current Source-drain current (pulsed)				15 60	A A
$V_{SD}^{(1)}$	Forward On Voltage	$I_{SD} = 15A$, $V_{GS} = 0$			1.3	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 15A$, $di/dt = 100A/\mu s$ $V_{DD} = 15V$, $T_j = 25^\circ C$ (see Figure 17)		22 32 1.9		ns nC A

1. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

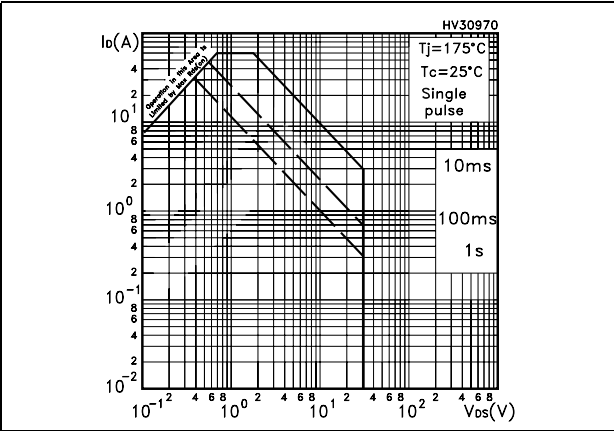


Figure 2. Thermal impedance

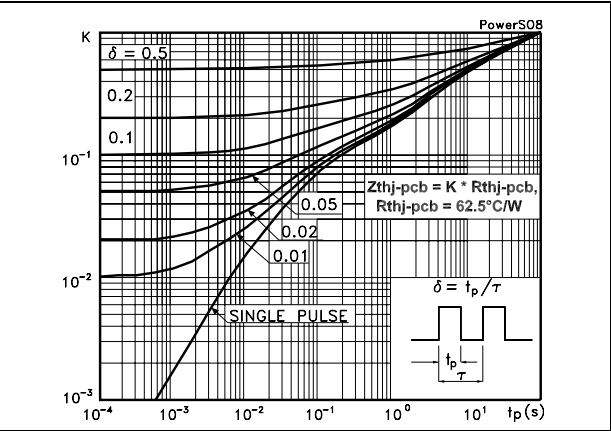


Figure 3. Output characteristics

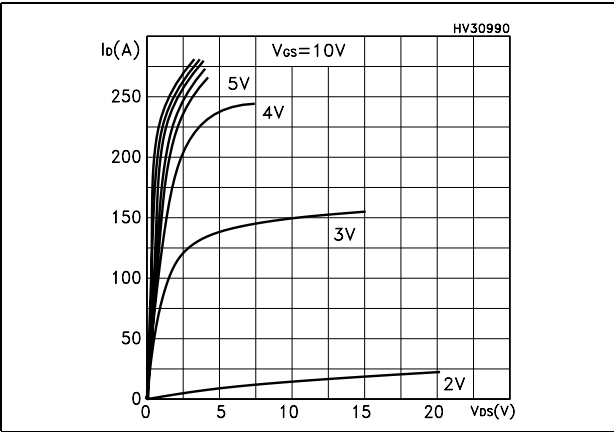


Figure 4. Transfer characteristics

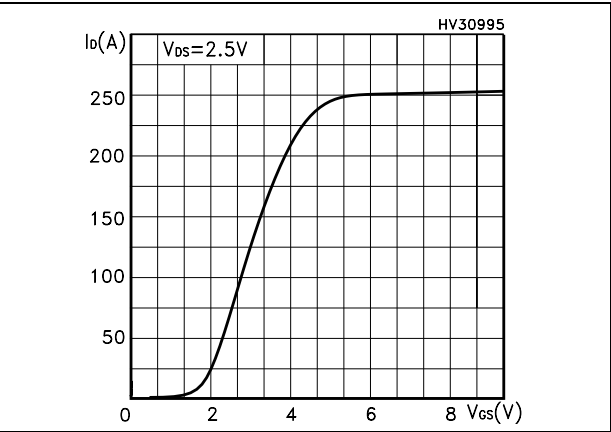


Figure 5. Normalized $B_{V_{DS}}$ vs temperature

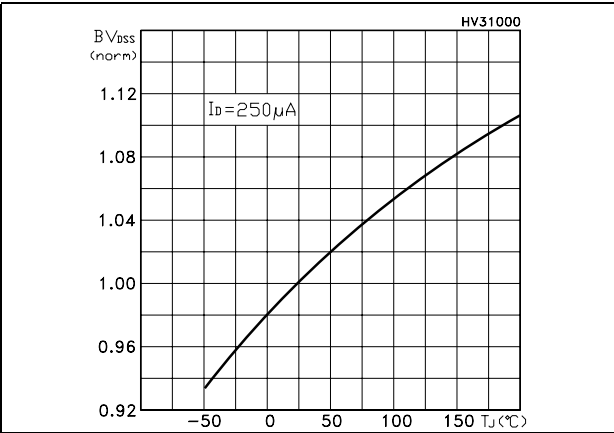


Figure 6. Static drain-source on resistance

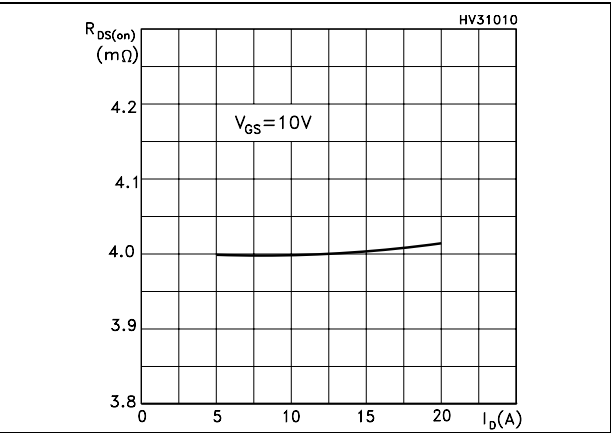


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

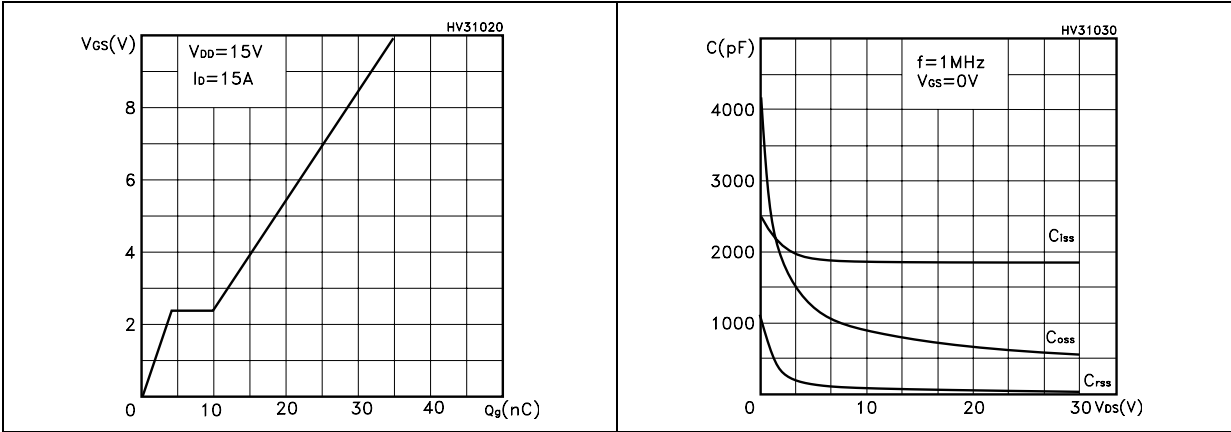


Figure 9. Normalized gate threshold voltage vs temperature Figure 10. Normalized on resistance vs temperature

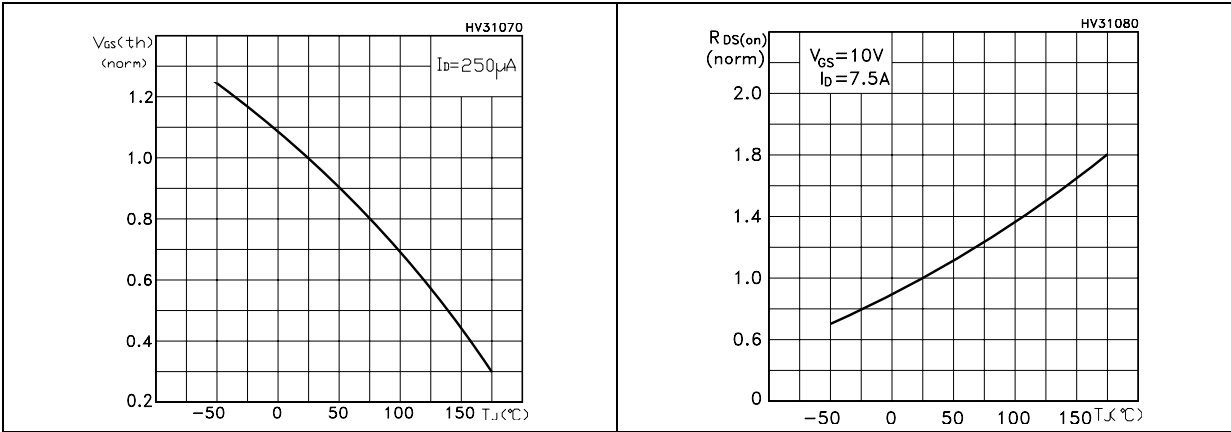
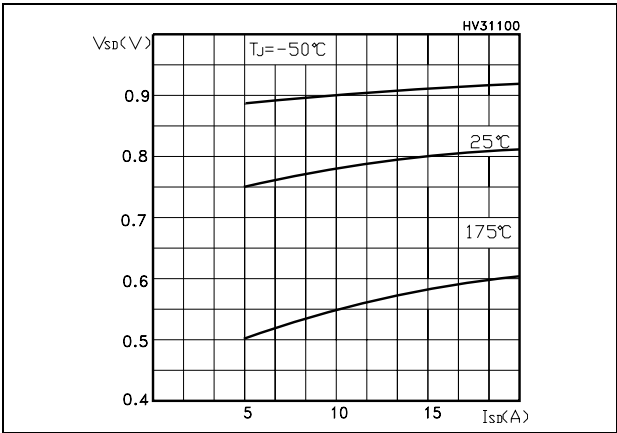


Figure 11. Source-drain diode forward characteristics



3 Test circuit

Figure 12. Switching times test circuit for resistive load

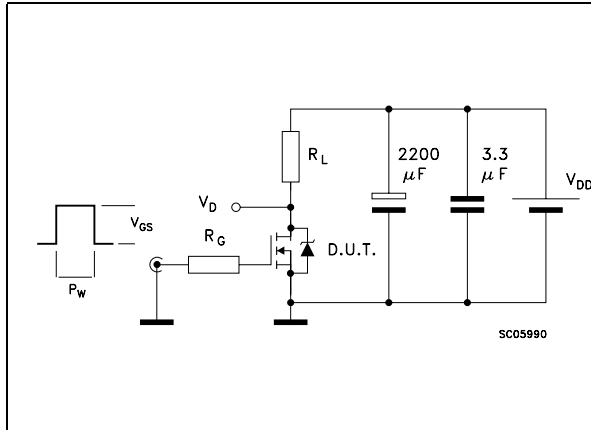


Figure 13. Gate charge test circuit

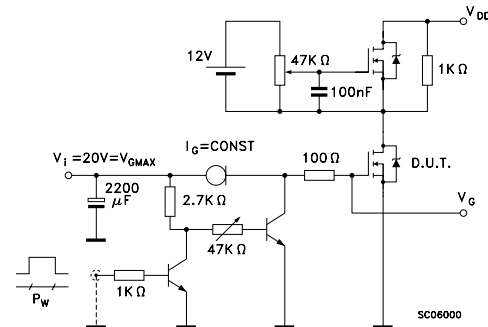


Figure 14. Test circuit for inductive load switching and diode recovery times

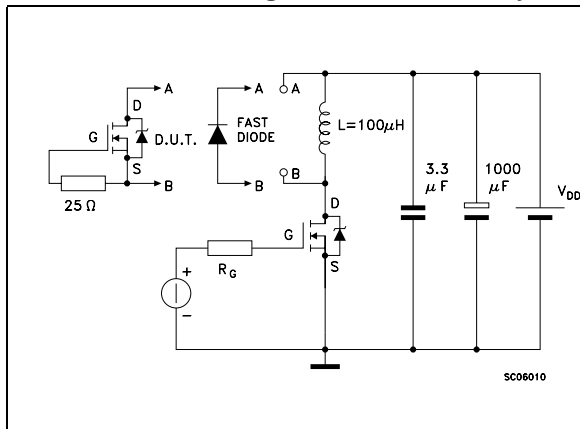


Figure 15. Unclamped inductive load test circuit

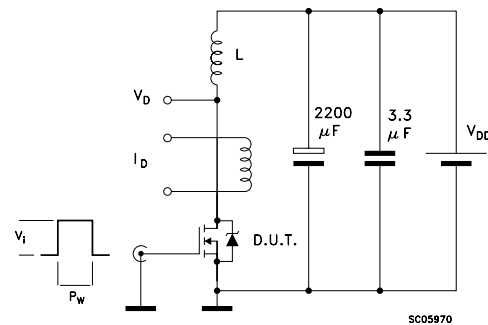


Figure 16. Unclamped inductive waveform

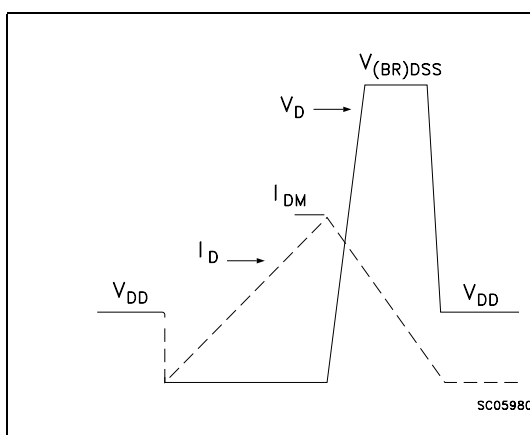
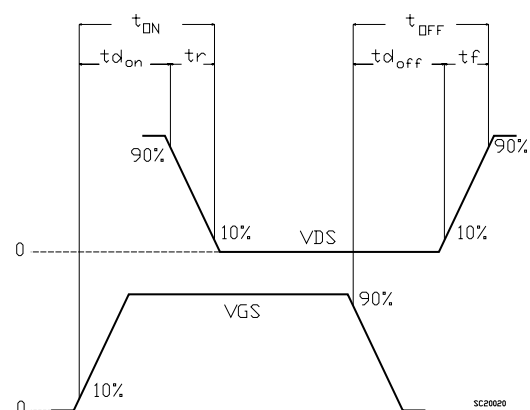


Figure 17. Switching time waveform

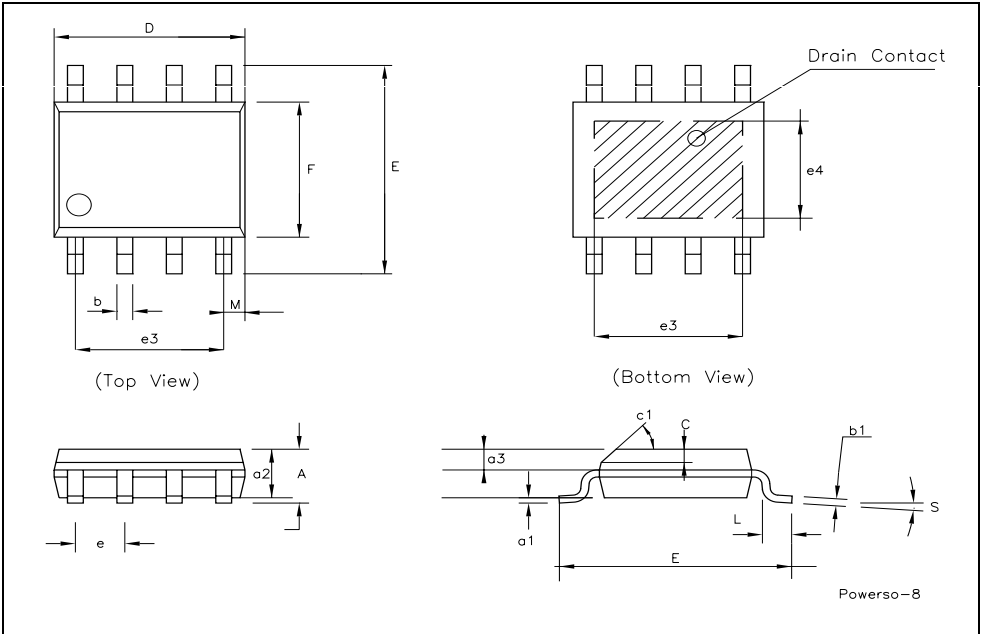


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

PowerSO-8™ MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
C	0.25		0.5	0.010		0.019
c1	45° (typ.)					
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
e4		2.79			0.110	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
S	8° (max.)					



5 Revision history

Table 7. Revision history

Date	Revision	Changes
12-Apr-2006	1	First release

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